

Search Notes



Application/Control No.

09/905,189

Examiner

JOHN PAK

Applicant(s)/Patent under Reexamination

WEI ET AL.

Art Unit

1616

SEARCHED

Class	Subclass	Date	Examiner
424	601-606 616	1/06	JP
514	532 533		
	546 547		
	557 558		
	560 574		
422	29		
510	375		
426	392 397		
426	399		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PG PUB		1/06	JP
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Inventor names searched	1/06	JP